## Application/Control No. Applicant(s)/Patent Under Reexamination 10/717,482 ABE, NAOTO Notice of References Cited Examiner Art Unit Page 1 of 1 2133 R. Stephen Dildine **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 713/193 US-2002/0035695 A1 Riches et al. 03-2002 713/193 Lee, Shyh-shin US-2002/0174353 A1 11-2002 В 713/193 Hayashi, Katsutoshi US-2003/0074572 A1 04-2003 С US-D US-Ε US-F US-G USн US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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